## Supplementary Material

## Role of Br-Cl distribution uniformity on the spectral stability of blue emitting mixed-halide perovskites

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Figure S1. Schematic illustration of the device configuration.



Figure S2. UV-vis absorption spectrum of CsPbClBr<sub>2</sub> doped with different

concentrations of p-F-PEABr.



**Figure S3.** (a) PL spectra, and (b) PLQY of CsPbClBr<sub>2</sub> doped with different concentrations of p-F-PEABr.



Figure S4. XRD patterns of CsPbClBr<sub>2</sub> doped with different concentrations of p-

F-PEABr.



Figure S5. SEM images of CsPbClBr<sub>2</sub> doped with different concentrations of p-

**F-PEABr:** (a) Control, (b) 20 %, (c) 40 %, (d) 60 %, (e) 80 %.



**Figure S6. The EL spectrum of the representative PeLEDs:** (a) Control, (b) 20% p-F-PEABr, (c) 40% p-F-PEABr, (d) 60% p-F-PEABr, (e) 80% p-F-PEABr.

## Table S1. EL peak shift of CsPbClBr<sub>2</sub> doped with different concentrations of p-F-PEABr.

p-F-PEABr (%)	EL peak at	EL peak at	Red shift of
	4V (nm)	6V (nm)	EL peak (nm)
0	481.8	483.3	1.5
20	480.3	484.3	4.0
40	477.1	485.0	7.9
60	476.3	486.6	10.3
80	471.6	481.9	10.3



Figure S7. XPS spectra of 3D and quasi-2D films before and after annealing: (a)

Cs 3d, (b) Pb 4f, (c) Br 3d, (d) Cl 2p.



Figure S8. (a) PL spectra, and (b) PLQY of 40% p-F-PEABr doped CsPbClBr<sub>2</sub> film after annealing at different annealing temperatures.



Figure S9. UV-vis spectra of 40% p-F-PEABr doped CsPbClBr<sub>2</sub> film after annealing at different annealing temperatures.



Figure S10. SEM images of 40% p-F-PEABr doped CsPbClBr<sub>2</sub> film after annealing at different annealing temperatures: (a) without annealing, (b) 100 °C, (c) 130 °C, (d) 160 °C.



**Figure S11. The EL spectrum of the representative PeLEDs at different annealing temperatures:** (a) without annealing, (b) 100 °C, (c) 130 °C, (d) 160 °C.

Table S2. EL peak shifts of 40% p-F-PEABr doped CsPbClBr<sub>2</sub> PeLEDs at different annealing temperatures.

Annealing	EL peak at	EL peak at 6	Red shift of
temperatures (°C)	4 V (nm)	V (nm)	EL peak (nm)
Without annealing	477.1	485.0	7.9
100	484.3	486.9	2.6
130	493.0	494.0	1.0
160	496.1	496.3	0.2



Figure S12. Molecular structures of p-F-PEA and DEA.



Figure S13. UV-vis spectra of CsPbClBr<sub>2</sub> films doped by different dopants.



**Figure S14.** (a) PL spectra, and (b) PLQY of 20% DEABr, and 20% DEACl doped CsPbClBr<sub>2</sub> films.



Figure S15. XRD patterns of 20% DEABr, and 20% DEACl doped CsPbClBr<sub>2</sub> films.



Figure S16. SEM images of 20% DEABr, and 20% DEACl doped CsPbClBr<sub>2</sub>

films: (a) Control, (b) 20% DEABr, (c) 20% DEACl.



**Figure S17. The EL spectra of the representative PeLEDs:** (a) Control, (b) 20% DEABr, (c) 20% DEACl.

Table S3. EL peak shifts of 20% DEABr, and 20% DEACl doped CsPbClBr<sub>2</sub> PeLEDs.

Emitter	EL peak at	EL peak at	Red shift of
	4V (nm)	6V (nm)	EL peak (nm)
Control	481.8	483.3	1.5
20% DEABr	481.9	482.2	0.3
20% DEACl	474.0	473.6	-0.4